Form PTO-1449					ATTY. DOCKET NO. 3430-0200P	NEW 10(75757)				
INFORMATION DISCLOSURE CITATION IN AN APPLICATION					APPLICANT Woong-Kwon KIM					
(Use several sheets if necessary)					FILING DATE January 15, 2003		GROUP Unassigned			
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL	DOCU	MENT NUMBER	Kind	DATE	NAME	CLASS	SUB CLASS		G DATE COPRIATE	
13	US	5,994,721	A	1999-11-30	ZHONG et al					
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OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.										
a	Pichon et al; "Low temperature unhydrogennated in-situ doped polysilicon thin film transistors: Toward a technology for flat panel displays"; Thin Solid Film, Vol. 296, pages 133-136, 1997.									
	·									
EXAMINER	EXAMINER Hoan Ngus on DATE CONSIDERED 8/3/104									
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